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Lead-free high-temperature dielectrics with wide operational range

Robert Dittmer,¹ Wook Jo,¹,a) Dragan Damjanovic,² and Jürgen Rödel¹
¹Institute of Materials Science, Technische Universität Darmstadt, Petersenstr. 23, 64287 Darmstadt, Germany
²Ceramics Laboratory, Swiss Federal Institute of Technology, EPFL, 1015 Lausanne, Switzerland
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The dielectric, electrical and structural properties of \((1-x)(0.94\text{Bi}_{1/2}\text{Na}_{1/2}\text{TiO}_3-0.06\text{BaTiO}_3)-x\text{K}_{0.5}\text{Na}_{0.5}\text{NbO}_3\) (BNT–BT–xKNN) with \(x=0.09, 0.12, 0.15,\) and 0.18 were investigated as potential candidates for high-temperature capacitors with a working temperature far beyond 200 °C. Temperature dependent dielectric permittivity \((\varepsilon)\) showed two local broad maxima that at the optimal composition of KNN \((x=0.18)\) are combined to form a plateau. This then results in a highly temperature-insensitive permittivity up to \(\sim 300\) °C at the expense of a small reduction in absolute permittivity values. High-temperature in situ x-ray diffraction study showed pseudocubic symmetry without obvious structural changes, which implies that the dielectric anomalies observed could only be a consequence of a slight change in space group. BNT–BT–0.18KNN showed a permittivity of \(\sim 2150\) at the frequency of 1 kHz at 150 °C with a normalized permittivity \(\varepsilon/\varepsilon_{150^\circ C}\) varying no more than \(\pm 10\%\) from 43 to 319 °C. With very good electrical properties persisting up to 300 °C, i.e., a resistivity on the order of magnitude of \(10^9\) Ω m and the RC constant of about 1 s, the examined BNT–BT–xKNN compositions present a good starting point for the development of high-temperature capacitor materials. © 2011 American Institute of Physics.
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I. INTRODUCTION

Capacitors are indispensable components for passive parts in contemporary electronic devices. They fulfill a variety of important functions including voltage smoothing, pulse discharge, filtering, dc blocking, coupling, decoupling, snubbing, and power conditioning.¹,² However, with increasing demands on the performance and efficiency of electronic systems, the requirements on capacitor materials imposed by the industries are increasing as well. The high-temperature electronics are of particular interest as control units are increasing as well. The high-temperature usually exhibit strongly reduced properties at elevated temperatures and thus are often limited to temperatures below 125 °C.³,⁴ Other dielectrics feature very high operational temperatures but either lack high permittivity or suffer from strong temperature dependence.⁵–¹² Bridger et al.¹³ showed that \(0.9(\text{Bi}_{1/2}\text{Na}_{1/2}\text{TiO}_3-0.1\text{KTaO}_3\) exhibits a relatively flat permittivity from 80 to 260 °C though permittivity outside this range rapidly decreases. Lim et al.¹⁴ have shown that the \(\text{BiScO}_3-\text{BaTiO}_3-(\text{K}_{1/2}\text{Bi}_{1/2})\text{TiO}_3\) (BSBT–KBT) pseudoternary system exhibits good electrical properties over a wide temperature range. However, the large free-

¹Electronic mail: jo@ceramics.tu-darmstadt.de.
Forcerency dispersion at low temperatures presents a serious drawback. Moreover, BSBT–KBT incorporates the element scandium which is also found in other materials that had been suggested for high-temperature dielectrics. The extraordinarily high price of scandium, however, limits the use of such materials to academic research. With regard to a potential application, it is vital to incorporate only those raw materials that are widely available with a reasonable price.

Zhang et al. investigated \((Bi_{1/2}Na_{1/2})TiO_3–BaTiO_3–(K_0.5Na_0.5)NbO_3\) (BNT–BT–KNN) pseudoternary systems mainly with respect to high electric field properties. Thereby, it was discovered that electric field induced phase changes cause large strain behavior in compositions with low KNN-content rendering them suitable for actuators. Materials with higher amounts of KNN were found to exhibit high electrostrictive constants and temperature-insensitive field-induced strain which are attractive for high-precision positioning devices and other actuators.

In this study, we report the electric and dielectric properties of \((1−x)[0.94BNT–0.06BT]−xKNN\) with \(x=0.09, 0.12, 0.15,\) and 0.18. The influence of the KNN-content on permittivity, loss factor, resistivity, and structure was investigated for temperatures from 30 up to 400 °C. We demonstrate that this material is promising as a dielectric for high-temperature applications owing to its very good dielectric and electric characteristics that can be achieved over a very broad operational temperature range.

II. EXPERIMENTAL

Ceramics were produced via a mixed oxide route using reagent grade oxides and carbonates (Alfa Aesar GmbH & Co. KG, Karlsruhe, Germany). First, \(Bi_2O_3\) (99.975%), \(Na_2CO_3\) (99.5%), \(TiO_2\) (99.9%), \(BaCO_3\) (99.8%), \(K_2CO_3\) (99.0%), and \(Nb_2O_5\) (99.9%) were mixed according to the stoichiometric formula and ball-milled in a planetary ball-mill (Fritsch Pulverisette 5, Idar-Oberstein, Germany) for 24 h at 250 rpm with zirconia balls in ethanol. After drying at 100 °C, the mixed powder was calcined at 900 °C for 3 h, and subsequently ball-milled again for 24 h. Pelleted and sieved powders were compacted into pellets of 10 mm in diameter. To facilitate the densification, powder compacts were hydrostatically pressed under 300 MPa. Sintering was performed at 1100 °C for 3 h in a covered alumina crucible with atmospheric powder of the same composition to minimize the loss of volatile elements. Finally the sintered pellets were ground, and polished. Samples were electroded with a silver paint on both sides and fired at 400 °C for 30 min.

Dielectric measurements were carried out with a HP4192A impedance analyzer (Hewlett-Packard Co., Pala Alto, CA, USA) using a Nabertherm LE4/11/R6 furnace (Nabertherm GmbH, Lilienthal, Germany) with a home-made sample holder at a heating rate of 2 K min\(^{-1}\). The leakage current was measured by means of a Keithley 6517B high resistance meter and a home-made furnace at a ramping rate of 4 K min\(^{-1}\) up to 400 °C under a dc voltage of 60 V. The \(RC\) constant was calculated from the capacitance at 1 kHz and the dc resistance.

Density was determined via the Archimedes method. For the microstructural analysis, samples were polished with diamond paste down to 0.25 μm and coated with a thin layer of carbon for subsequent observation in the scanning electron microscope L30 FE/ESM (Philips/FEI, Hillsboro, OR, USA). The average grain size was determined from the mean intercept length multiplied by 1.56. Room temperature structure was characterized by a powder x-ray diffraction (XRD, STADI P STOE, Darmstadt, Germany) with a transmission geometry using Cu \(K\alpha_1\) radiation. To release stress induced during the sample preparation stage, the crushed powders were thermally annealed at 400 °C for 1 h. For the temperature dependent structural analysis, a reflective XRD apparatus (Bruker AXS D8, Karlsruhe, Germany) equipped with a furnace was employed using Cu \(K\alpha\) radiation.

III. RESULTS AND DISCUSSION

Figure 1 illustrates a segment of the pseudo-ternary phase diagram of the BNT-BT-KNN system showing the location of the four compositions examined. These are \((1−x)\times[0.94BNT–0.06BT]−xKNN\) with \(x=0.09, 0.12, 0.15,\) and 0.18, which will be termed 9KNN, 12KNN, 15KNN, and 18KNN in the following. Note that all four compositions are a derivative of the base composition 0.94BNT–0.06BT, which lies at the morphotropic phase boundary between rhombohedral BNT and tetragonal BT. Using room-temperature XRD, it was confirmed that all four compositions were successfully synthesized as single phase materials that show pseudocubic structure.

The average grain size \(G\) and the relative density \(\rho\) of the materials studied are summarized in Table I. The KNN content has little influence both on the density and on the average grain size. All four specimens showed a very homogeneous microstructure with practically the same average grain

<table>
<thead>
<tr>
<th>Composition</th>
<th>Grain Size (μm)</th>
<th>Density (%)</th>
</tr>
</thead>
<tbody>
<tr>
<td>9KNN</td>
<td>0.5 ± 0.1</td>
<td>98 ± 0.5</td>
</tr>
<tr>
<td>12KNN</td>
<td>0.5 ± 0.1</td>
<td>98 ± 0.3</td>
</tr>
<tr>
<td>15KNN</td>
<td>0.6 ± 0.1</td>
<td>98 ± 0.7</td>
</tr>
<tr>
<td>18KNN</td>
<td>0.5 ± 0.1</td>
<td>96 ± 0.3</td>
</tr>
</tbody>
</table>
size of ≈0.5 μm, and the relative density of >96%. The fact that fairly dense specimens with submicron-sized grains are available by a conventional sintering technique in the current system is highly promising from the industrial point of view, since it is an essential prerequisite for mass production and miniaturization of multilayer ceramic capacitors.

Figure 2 provides the temperature dependent dielectric permittivity and loss factor from room temperature up to 400 °C for all the compositions studied. Two distinctive dielectric anomalies are discerned common to BNT-based materials. The first dielectric anomaly at ≈100 °C involves a frequency dependent dielectric permittivity, which is known as one of the distinctive features characterizing relaxor ferroelectrics. In fact, the changes in loss tangent also support the assumption that the material has relaxor characteristic. The other dielectric anomaly appears at ≈250 °C showing neither frequency dispersion nor abrupt changes in loss factor. Comparison of the plots for all the compositions investigated clearly rationalizes the effect of KNN which is to render the permittivity values insensitive to temperature. Here, the temperatures that designate the first and the second dielectric anomaly are referred to as T_{m1} and T_{m2}, respectively, and are summarized in Fig. 3. It is demonstrated that T_{m1} decreases while T_{m2} increases with increasing KNN content. At the same time, the permittivity values at both temperatures are reduced. The increase in ΔT(T_{m2}−T_{m1}) and the reduction in the permittivity values are responsible for the expansion of the range of working temperature and for the temperature insensitivity, respectively. Feasibility of the studied materials as high temperature dielectrics is further quantified in Fig. 4.

The permittivity normalized to the permittivity at 150 °C ε/ε_{150 °C} is plotted at 1 kHz. The dotted and the dashed frames indicate the operational ranges with ±5% and ±10% tolerance, respectively. For ±5% tolerance the operational range increases from 109−292 °C to 53−294 °C. This is a remarkably flat progression of the permittivity considering that there is less than 5% variation in a range that spans over 240 K, reaching almost 300 °C in 18KNN. For a ±10% tolerance the working temperature spans from 96−313 °C in 9KNN to 43−319 °C in 18KNN. This small deviation in permittivity is a notable feature since the Electronic Industries Alliance (EIA) permits ±15% deviations for commercially available X7R capacitors that are currently designated for operation at elevated temperatures.

Albeit limited to 125 °C, those X7R materials exhibit advantages at low temperatures down to −55 °C. In contrast, the permittivity of the materials presented here decreases gradually when the temperature drops below T_{m1}. Therefore, it would be beneficial to shift T_{m1} below room temperature, e.g., by means of additional chemical substitutions.

![FIG. 2. (Color online) Permittivity and loss factor for (a) 9KNN, (b) 12KNN, (c) 15KNN, and (d) 18KNN at different frequencies.](image)

![FIG. 3. (Color online) Evolution of characteristic temperatures and permittivity values with KNN content (data at 1 kHz, T_{m1} and T_{m2} derived from first derivative of permittivity).](image)

![FIG. 4. (Color online) Change in permittivity at 1 kHz (at 150 °C) and illustration of operational range for deviation of ±5% (dotted frame) and ±10% (dashed frame) for (a) 9KNN, (b) 12KNN, (c) 15KNN, and (d) 18KNN.](image)
FIG. 5. (Color online) Resistivity as function of inverse absolute temperature measured at 60 Vdc.

could not only expand the operational temperature range but potentially also may eliminate the frequency dispersion at room temperature.

High permittivity, temperature stability, and low loss are not the only key figures; for the application as a capacitor, the dielectric material is required to have both high resistivity and RC constant even at elevated temperatures. Although an ideal capacitor would have an infinite resistivity, all real capacitors have a finite value for its resistivity. Hence, a charged capacitor will have a leakage current and will discharge through its own resistance. Because of this, a capacitive device of higher performance is obtained by higher resistivity. Figure 5 illustrates that resistivity is very similar among the four BNT–BT–KNN materials from 100 to 400 °C.

Compared with soft PZT, which has a resistivity in the order of magnitude of $10^{12}$ Ω m at room temperature, the resistivity obtained for the BNT–BT–KNN materials at 100 °C is comparably high as it lies in the range of $10^{11}–10^{12}$ Ω m. For all compositions, the resistivity drops exponentially showing Arrhenius behavior with predominantly linear curves in the logarithmic plot against inverse absolute temperature. The activation energy $E_a$ for the electrical conductivity is 0.82 eV (9KNN), 0.74 eV (12KNN), 1.04 eV (15KNN), and 0.77 eV (18KNN) in the range from 100 to 300 °C. At 300 °C the resistivity is in the order of magnitude of $10^8$ Ω m, outperforming PZT5A with $1.9 \times 10^7$ Ω m, 0.36BiScO$_3$–0.64PbTiO$_3$ (BSPT64) with $2.4 \times 10^6$ Ω m or (Pb,Ba)Nb$_2$O$_6$ with $10^5$ Ω m.

The time dependence of a discharging process of a capacitor is determined by the time constant $\tau$ according to Eq. (1).

$$Q(t) = Q_0 \exp \left( -\frac{t}{\tau} \right).$$

Here $Q(t)$ is the charge at time $t$ and $Q_0$ is the initial charge. The time constant $\tau$ is defined as

$$\tau = R \cdot C$$

with the resistance $R$ and the capacitance $C$. At $t=\tau$ the capacitance drops to $e^{-1}$ (≈37%) of the initial value, and hence $RC$ is a measure for the quality of a material to maintain its charge. Therefore, a high $RC$ value is synonymous for high capacitance and high resistance at the same time. Figure 6 provides a comparison of the $RC$ value at 300 °C for four BNT–BT–KNN compositions with reference to other potential candidates for high temperature dielectrics.

The addition of KNN reduces the $RC$ constant at 300 °C from 2.64 s for 9KNN to 1.13 s for 18KNN. These values are comparably high surpassing those of other materials such as 0.8,$(0.4$BiScO$_3$–$0.6$BaTiO$_3$)$–0.2$BiTi$_2$(K$_{12}$)$TiO_3$ (BSBT–20BKT), PZT5A or BSPT64. The high $RC$ values of BNT–BT–KNN outperform materials with toxic elements such as lead or expensive elements such as scandium and beyond that BNT–BT–KNN features the aforementioned high permittivity over a broad temperature range. Tailoring both resistivity and $RC$ constant further by dopants as already demonstrated for other material systems is encouraged for the future.

As already discussed, the reason behind the broad plateau in temperature dependent permittivity appears to be due to two distinct dielectric anomalies that are gradually smeared into each other as KNN content increases. Of course, the physical origin behind these two anomalies has to be clarified in order to fully understand and further optimize these materials. A similar characteristic of $\varepsilon(T)$ is already known from the parent pseudobinary BNT–BT system, which also shows two nearby local maxima though very different in magnitude.

High-temperature in situ XRD measurements were performed from room temperature up to 300 °C for 18KNN. No obvious noncubic distortion was detected within the analyzed temperature range. However, the changes in intensity indicate that there are at least two successive structural changes taking place. Note that a discontinuous change in the intensity of (110)$_{pc}$ peak (the subscript “pc” here refers to pseudocubic) is clearly seen in the temperature range of about 150–240 °C in Fig. 7.

Hinterstein et al. demonstrated by combining neutron with XRD techniques that the introduction of KNN to BNT–6BT stabilizes the high temperature $P4bm$ phase at room temperature, the lattice distortion of which is so small $[c/a$
warrants further systematic investigations.

point in the temperature-dependent dielectric permittivity where dielectric dispersion disappears with an inflection 160 °C is closely correlated with the temperature regime actually structure change implied by the XRD study at about 43 to 319 °C. It is interesting to note that though the first dielectric anomaly of 18KNN effectively detectable only by neutron diffraction. In addition, the fact that no obvious structural change is observed from 43 to 319 °C. The evolution in 18KNN is given in terms of the XRD length reflection for 18KNN remains virtually perfectly from Cu Kα1 and Cu Kα2 wavelength). The (110) reflection of 18KNN is sensitive to the presence of superlattice reflection, which is properly detectable only by neutron diffraction. In addition, Webber et al.30 showed that there is an additional phase $P4/mnbm$ (or $P4/mmm$), which is paraelectric but ferroelastic, between the tetragonal $P4bm$ and the cubic $Pm\bar{3}m$ in the BNT–6BT system. It is thus suggested that the structural evolution in 18KNN is given in terms of the XRD length scale as

\begin{align*}
\sim 160 ^{\circ} C & \quad P4bm (FE/FEla) \rightarrow P4/mnbm (PE/FEla) \\
\sim 250 ^{\circ} C & \quad \rightarrow Pm\bar{3}m (PE/PEla),
\end{align*}

where $FE$, $PE$, $FEla$, and $PEla$ denote ferroelectric, paraelectric, ferroelastic, and paraelastic, phases, respectively. It is interesting to note that though the first dielectric anomaly of 18KNN (see Fig. 2) is observed below 100 °C, the fact that no obvious structural change is observed from the in situ XRD study strongly supports the assumption that BNT–BT–KNN is a relaxor.52 It is interesting to note that the actual structure change implied by the XRD study at about 160 °C is closely correlated with the temperature regime where dielectric dispersion disappears with an inflection point in the temperature-dependent dielectric permittivity data. However, any physical reasoning for the correlation warrants further systematic investigations.

IV. CONCLUSIONS

Potential compositions for high temperature dielectric applications were developed in a pseudoternary lead-free BNT–BT–KNN system. These commercially viable cost-effective materials provide not only temperature insensitivity but also a wide operational temperature range. Among the studied compositions, 18KNN was shown to offer $>270 ^{\circ} C$ (from 43 to 319 °C) of reliable operation temperature window and $\Delta e/e_{150 ^{\circ} C} < 10\%$ with concurrent permittivity values exceeding 2000. Furthermore, its resistivity is comparatively high throughout the measured temperature range with an $R\cdot C$ constant of about 1 s at 300 °C. We suggest that the materials presented render a good starting point for the development of high-capacitance, cost-effective capacitors for high-temperature application beyond 200 °C.

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